



RADIO TEST REPORT

Test Report No. : 11201776H-D-R1

Applicant : **KEYENCE CORPORATION**
Type of Equipment : **Handheld Mobile Computer**
Model No. : **BT-W75GA**
FCC ID : **RF41395A**
Test regulation : **FCC Part 15 Subpart E: 2016**
(DFS test only)
Test Result : **Complied**

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
7. This report is a revised version of 11201776H-D. 11201776H-D is replaced with this report.

Date of test: May 10, 2016

Representative test engineer:

T. Shimada

Takumi Shimada
Engineer

Consumer Technology Division

Approved by:

Takayuki Shimada

Takayuki Shimada
Engineer

Consumer Technology Division



NVLAP LAB CODE: 200572-0

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13-EM-F0429

<u>CONTENTS</u>	<u>PAGE</u>
SECTION 1: Customer information.....	4
SECTION 2: Equipment under test (E.U.T.).....	4
SECTION 3: Scope of Report.....	7
SECTION 4: Test specification, procedures & results.....	7
SECTION 5: Operation of E.U.T. during testing.....	12
SECTION 6: Channel Move Time, Channel Closing Transmission Time.....	18
SECTION 7: Non-Occupancy Period.....	20
APPENDIX 1: Test instruments	22
APPENDIX 2: Photographs of test setup.....	23

Radio Specification

Radio Type : Transceiver
Power Supply (inner) : DC 1.8 V / DC 3.3 V

	IEEE802.11b	IEEE802.11g/n (20 M band)	IEEE802.11a/n (20 M band) *1)	IEEE802.11n (40 M band) *1)
Frequency of operation	2412 MHz - 2462 MHz	2412 MHz - 2462 MHz	5180 MHz - 5240 MHz 5280 MHz - 5320 MHz 5500 MHz - 5580 MHz 5660 MHz - 5700 MHz 5745 MHz - 5825 MHz	5190 MHz - 5230 MHz 5310 MHz 5510 MHz - 5550 MHz 5670 MHz 5755 MHz - 5795 MHz
Type of modulation	DSSS (CCK, DQPSK, DBPSK)	OFDM-CCK (64QAM, 16QAM, QPSK, BPSK)	OFDM (64QAM, 16QAM, QPSK, BPSK)	
Channel spacing	5MHz		20MHz	40MHz
Antenna type	Multilayer Monopole Antenna			
Antenna Connector type	Soldering			
Antenna Gain	2.1 dBi (2.4 GHz)		2.4 dBi (5 GHz)	

	Bluetooth Ver.2.1 with EDR function
Frequency of operation	2402 MHz - 2480 MHz
Type of modulation	FHSS (GFSK, $\pi/4$ -DQPSK, 8-DPSK)
Channel spacing	1 MHz
Antenna type	Multilayer Monopole Antenna
Antenna Connector type	Soldering
Antenna Gain	2.1 dBi

*1) This test report applies to WLAN (5 GHz band) part.
*Wireless LAN and Bluetooth do not transmit simultaneously.

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Variant model

This model has a variant model: BT-W70GA.

BT-W70GA is a Laser-type handy scanner. BT-W75GA is a Camera-type handy scanner.

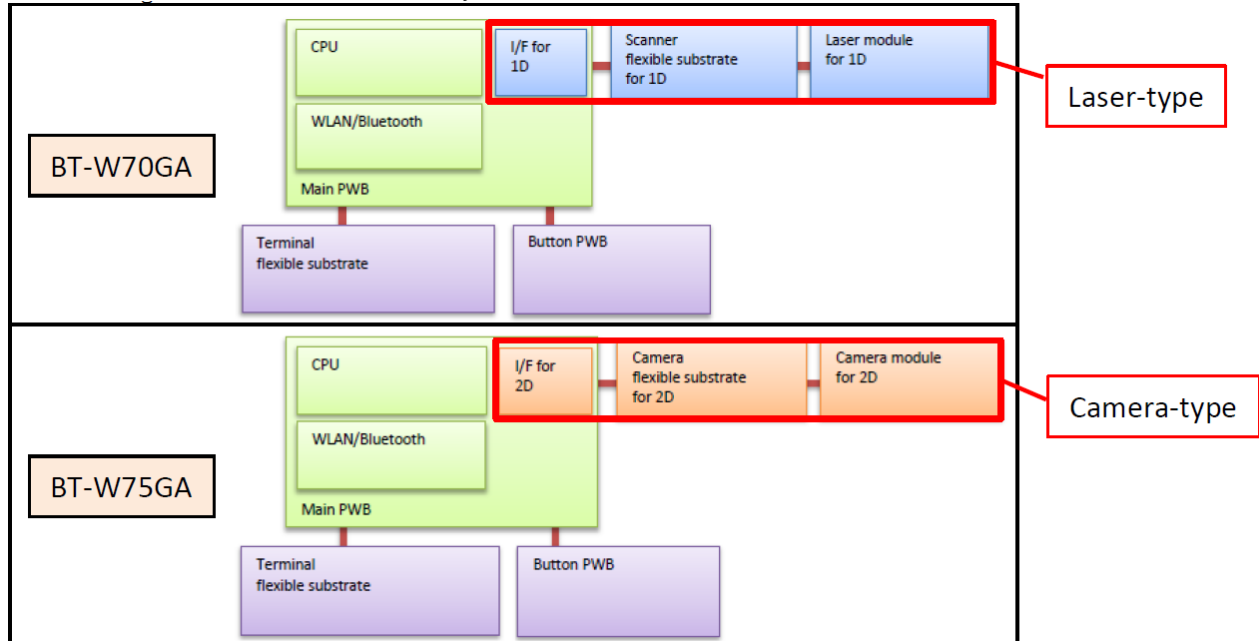
The schematic differences between BT-W70GA and BT-W75GA are the following diagrams.

Circuit design related with WLAN/Bluetooth is same between 2 models.

These difference cause no influence to radio specification.

There was no degradation of EMC characteristic.

Therefore we can consider them electrically identical.



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SECTION 3: Scope of Report

This report only covers DFS requirement, as specified by the following referenced procedures.

SECTION 4: Test specification, procedures & results

4.1 Test Specification

Test Specification	:	FCC Part 15 Subpart E FCC part 15 final revised on April 6, 2016.
Title	:	FCC 47CFR Part15 Radio Frequency Device Subpart E Unlicensed National Information Infrastructure Devices Section 15.407 General technical requirements
Test Specification Title	:	KDB905462 D02 UNII DFS Compliance Procedures New Rules v02 COMPLIANCE MEASUREMENT PROCEDURES FOR UNLICENSED- NATIONAL INFORMATION INFRASTRUCTURE DEVICES OPERATING IN THE 5250-5350MHz AND 5470-5725MHz BANDS INCORPORATING DYNAMIC FREQUENCY SELECTION
Test Specification Title	:	KDB905462 D03 Client Without DFS New Rules v01r01 U-NII CLIENT DEVICES WITHOUT RADAR DETECTION CAPABILITY

FCC Part 15.31 (e)

The test was performed with the New Battery (DC 4.2 V) and the EUT constantly provides the stable voltage to RF part through the regulator regardless of input voltage from New Battery. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

4.2 Procedures and results

Table 1: Applicability of DFS Requirements

Requirement	Operating Mode	Test Procedures & Limits	Deviation	Results
	Client without Radar Detection			
U-NII Detection Bandwidth	Not required	KDB905462 D02 UNII DFS Compliance Procedures New Rules v02	N/A	N/A
Initial Channel Availability Check Time	Not required	FCC15.407 (h)	N/A	N/A
		KDB905462 D02 UNII DFS Compliance Procedures New Rules v02		
		RSS-247 6.3		
Radar Burst at the Beginning of the Channel Availability Check Time	Not required	FCC15.407 (h)	N/A	N/A
		KDB905462 D02 UNII DFS Compliance Procedures New Rules v02		
		RSS-247 6.3		
Radar Burst at the End of the Channel Availability Check Time	Not required	FCC15.407 (h)	N/A	N/A
		KDB905462 D02 UNII DFS Compliance Procedures New Rules v02		
		RSS-247 6.3		
In-Service Monitoring for Channel Move Time, Channel Closing Transmission Time	Yes	FCC15.407 (h)	N/A	Complied
		KDB905462 D02 UNII DFS Compliance Procedures New Rules v02		
		RSS-247 6.3		
In-Service Monitoring for Non-Occupancy period	Yes *	FCC15.407 (h)	N/A	Complied
		KDB905462 D02 UNII DFS Compliance Procedures New Rules v02		
		RSS-247 6.3		
Statistical Performance Check	Not required	FCC15.407 (h)	N/A	N/A
		KDB905462 D02 UNII DFS Compliance Procedures New Rules v02		

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0422.

*Although this test was not required in FCC, KDB 905462 D02, it was performed as additional test.

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Table 2 DFS Detection Thresholds for Master Devices and Client Devices With Radar Detection

Maximum Transmit Power	Value (See Notes 1,2, and 3)
≥ 200 milliwatt	-64 dBm
< 200 milliwatt and power spectral density < 10dBm/MHz	-62 dBm
< 200 milliwatt that do not meet the power spectral density requirement	-64 dBm
Note 1: This is the level at the input of the receiver assuming a 0 dBi receive antenna. Note 2: Throughout these test procedures an additional 1 dB has been added to the amplitude of the test transmission waveforms to account for variations in measurement equipment. This will ensure that the test signal is at or above the detection threshold level to trigger a DFS response. Note 3: EIRP is based on the highest antenna gain. For MIMO devices refer to KDB Publication 662911 D01.	

Table 3 DFS Response Requirement Values

Parameter	Value
Non-occupancy period	Minimum 30 minutes
Channel Availability Check Time	60 seconds
Channel Move Time	10 seconds See Note 1
Channel Closing Transmission Time	200 milliseconds + an aggregate of 60 milliseconds over remaining 10 second period. See Notes 1 and 2
U-NII Detection Bandwidth	Minimum 100 % of the U-NII 99 % transmission power bandwidth See Note 3
Note 1: Channel Move Time and the Channel Closing Transmission Time should be performed with Radar Type 0. The measurement timing begins at the end of the Radar Type 0 burst. Note 2: The Channel Closing Transmission Time is comprised of 200 milliseconds starting at the beginning of the Channel Move Time plus any additional intermittent control signals required to facilitate a Channel move (an aggregate of 60 milliseconds) during the remainder of the 10 second period. The aggregate duration of control signal will not count quiet periods in between transmissions. Note 3: During the U-NII Detection Bandwidth detection test, radar type 0 should be used. For each frequency step the minimum percentage of detection is 90 percent. Measurements are performed with no data traffic.	

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Table 4 Short Pulse Radar Test Waveform

Radar Type	Pulse Width (μsec)	PRI (μsec)	Number of Pulses	Minimum Percentage of Successful Detection	Minimum Number of Trials
0	1	1428	18	See Note 1	See Note 1
1	1	Test A: 15 unique PRI values randomly selected from the list of 23 PRI values in Table 5a	Roundup $\{(1/360) * (19 * 10^6 / \text{PRI}_{\mu\text{sec}})\}$	60 %	30
		Test B: 15 unique PRI values randomly selected within the range of 518-3066 μsec, with a minimum increment of 1 μsec, excluding PRI values selected in Test A			
2	1-5	150-230	23-29	60 %	30
3	6-10	200-500	16-18	60 %	30
4	11-20	200-500	12-16	60 %	30
Aggregate (Rader Types 1-4)				80 %	120
Note 1: Short Pulse Radar Type 0 should be used for the detection bandwidth test, channel move time, and channel closing time tests.					

Table 5 Long Pulse Radar Test Waveform

Radar Type	Pulse Width (μsec)	Chip Width (MHz)	PRI (μsec)	Number of Pulses per Burst	Number of Burst	Minimum Percentage of Successful Detection	Minimum Number of Trials
5	50-100	5 - 20	1000-2000	1-3	8-20	80 %	30

Table 6 Frequency Hopping Radar Test Waveform

Radar Type	Pulse Width (μsec)	PRI (μsec)	Pulse per Hop (kHz)	Hopping Rate (kHz)	Hopping Sequence Length (msec)	Minimum Percentage of Successful Detection	Minimum Number of Trials
6	1	333	9	0.333	300	70 %	30

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4.3 Test Location

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	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	4.0 x 4.5 x 2.7m	4.0 x 4.5 m	-
No.6 measurement room	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	8.0 x 4.6 x 2.8m	2.4 x 2.4m	-
No.11 measurement room	-	6.2 x 4.7 x 3.0m	4.8 x 4.6m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

4.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.
Time Measurement uncertainty for this test was: (±) 0.012%

4.5 Test instruments of DFS, Test set up

Refer to APPENDIX.

SECTION 5: Operation of E.U.T. during testing

5.1 Operating Modes

Operation frequencies: Please see page 5.

The channel-loading of approximately 17% or greater was used for testing, and its test data was transferred from the Master Device to the Client Device for all test configurations.

The EUT utilizes the 802.11a/n architecture, with a 20MHz, and 40MHz channel bandwidth.

The FCC ID for the Master Device used with EUT for DFS testing is LDK102087.

The rated output power of the Master unit is >200 mW(23dBm). Therefore the required interference threshold level is -64 dBm. After correction for antenna gain and procedural adjustments, the required conducted threshold at the antenna port is $-64 + 1 + 0 = -63.0$ dBm (threshold level + additional 1dB + antenna gain).

It is impossible for users to change DFS control, because the DFS function is written on the firmware and users cannot access it.

The EUT was set by the software as follows:

Software name & version: HW: Same as production model, SW: Same as production model

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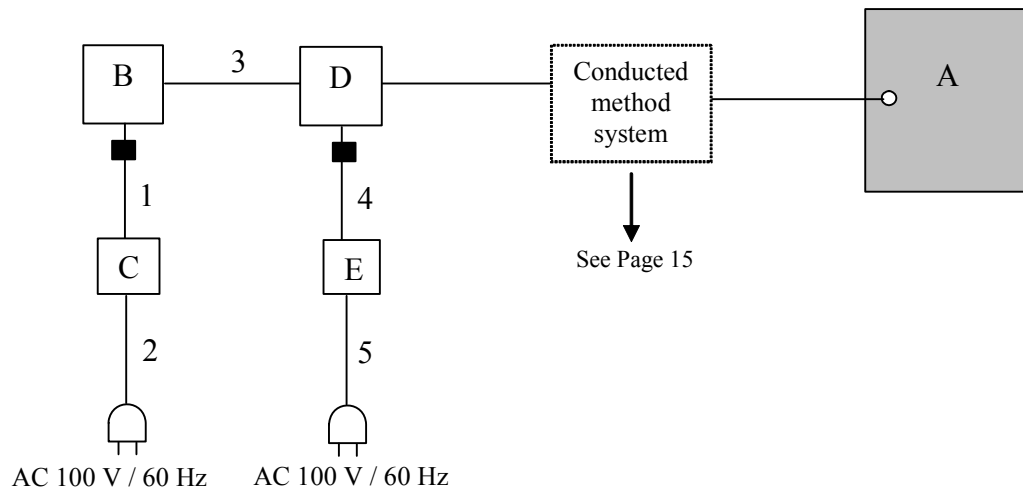
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5.2 Configuration and peripherals



■ : Standard Ferrite Core

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Handheld Mobile Computer	BT-W75GA	#2A610013	KEYENCE CORPORATION	EUT
B	Laptop PC	T60	L3-DM302	IBM	-
C	AC Adaptor	92P1160	11S92P1160Z1ZBG H6B6DKV	IBM	-
D	Wireless LAN access point	AIR-CAP3702E-A-K9	FTX182276QC	Cisco Systems	-
E	AC Adaptor	AA25480L	ALD030406GR	Cisco Systems	-

List of cables used

No.	Name	Length (m)	Shield	
			Cable	Connector
1	DC Cable	1.8	Unshielded	Unshielded
2	AC Cable	0.9	Unshielded	Unshielded
3	LAN Cable	3.0	Unshielded	Unshielded
4	DC Cable	1.9	Unshielded	Unshielded
5	AC Cable	2.1	Unshielded	Unshielded

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5.3 Test and Measurement System

SYSTEM OVERVIEW

The measurement system is based on a conducted test method.

The software selects waveform parameters from within the bounds of the signal type on a random basis using uniform distribution. The short pulse types 2, 3, and 4, the long pulse type 5, and the frequency hopping type 6 parameters are randomized at run-time.

The signal monitoring equipment consists of a spectrum analyzer with the capacity to display 8001 bins on the horizontal axis. A time-domain resolution of 2 msec/bin is achievable with a 16 second sweep time, meeting the 10 seconds short pulse reporting criteria. The aggregate ON time is calculated by multiplying the number of bins above a threshold during a particular observation period by the dwell time per bin, with the analyzer set to peak detection. A time-domain resolution of 3 msec/bin is achievable with a 24 second sweep time, meeting the 22 second long pulse reporting criteria and allowing a minimum of 10 seconds after the end of the long pulse waveform.

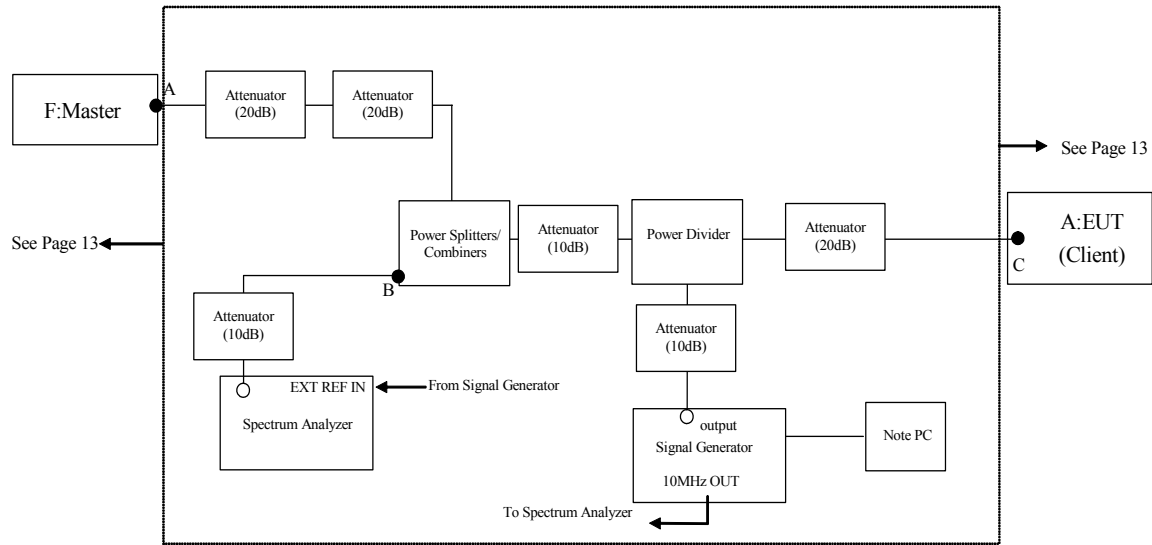
FREQUENCY HOPPING RADAR WAVEFORM GENERATING SUBSYSTEM

The first 100 frequencies are selected out of the hopping sequence of the randomized 475 hop frequencies.

Only a *Burst* that has the frequency falling within the receiver bandwidth of the tested U-NII device is selected among those frequencies. (Frequency-domain simulation). The radar waveform generated at the start time of the selected *Burst* (Time-domain simulation) is download to the Signal Generator.

If all of the randomly selected 100 frequencies do not fall within the receiver bandwidth of the U-NII device, the radar waveform is not used for the test.

CONDUCTED METHODS SYSTEM BLOCK DIAGRAM



MEASUREMENT SYSTEM FREQUENCY REFERENCE

Lock the signal generator and the spectrum analyzer to the same reference sources as follows: Connect the 10 MHz OUT on the signal generator to the EXT REF IN on the spectrum analyzer and set the spectrum analyzer Ext to On.

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SYSTEM CALIBRATION

Step 1: Set the system as shown in Figure 3 of KDB905462 7.2.2.

Step 2: Adjust each attenuator to fulfill the following three conditions:

- WLAN can be communicated, and
- Radar detection threshold level is bigger than Client Device traffic level on the spectrum analyzer, and
- Master Device traffic level is not displayed on the spectrum analyzer.

Step 3: Terminate 50 ohm at B and C points, and connect the spectrum analyzer to the point A. (See the figure on page 15)

At the point A, adjust the signal generator and spectrum analyzer to the center frequency of the channel to be measured.

Download the applicable radar waveforms to the signal generator. Select the radar waveform, trigger a burst manually and measure the amplitude on the spectrum analyzer. Readjust the amplitude of the signal generator as required so that the peak level of the waveform is at a displayed level equal to the required or desired interference detection threshold.

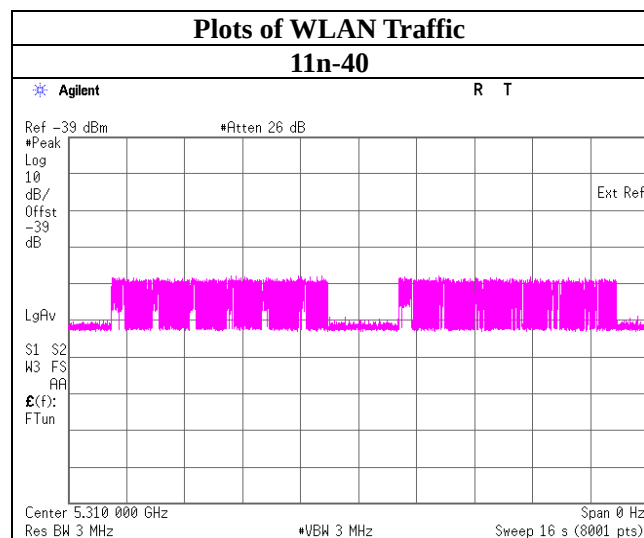
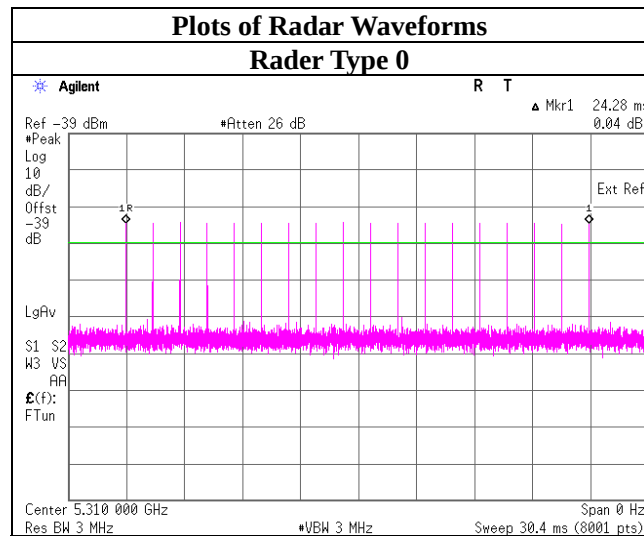
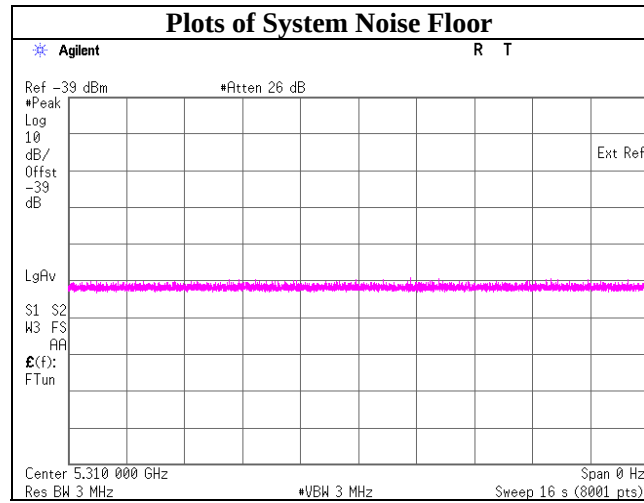
Separate signal generator amplitude settings are determined as required for each radar type.

Step 4: Without changing any of the instrument settings, restore the system setting to Step 2 and adjust the Reference Level Offset of the spectrum analyzer to the level at Step 3.

By taking the above steps 1 to 4, the spectrum analyzer displays the level of the signal generator as received at the antenna ports of the Master Device.

See Clause 5.4 for Plots of Noise, Radar Waveforms, and WLAN signals.

5.4 Plots of Noise, Rader Waveforms, and WLAN signals



SECTION 6: Channel Move Time, Channel Closing Transmission Time

6.1 Operating environment

Test place : Ise EMC Lab.No.6 shielded room
Date : 05/10/2016
Temperature/ Humidity : 24deg. C / 62% RH
Engineer : Takumi Shimada
Mode : 11n-40

6.2 Test Procedure

Transmit the data from the Master Device to the Client Device on the test Channel for the entire period of the test. The Radar Waveform generator sends a Burst of pulses for one of the Radar Types 0 at levels defined on the Operating Channel. An additional 1 dB is added to the radar test signal to ensure it is at or above the DFS Detection Threshold, accounting for equipment variations/errors. Observe the transmissions of the EUT at the end of the radar Burst on the Operating Channel for duration greater than 10 seconds.

6.3 Test data

11n-40

Test Item	Unit	Measurement Time	Limit	Results
Channel Move Time *1)	[sec]	0.072	10.000	Pass
Channel Closing Transmission Time *2)	[msec]	0	60	Pass

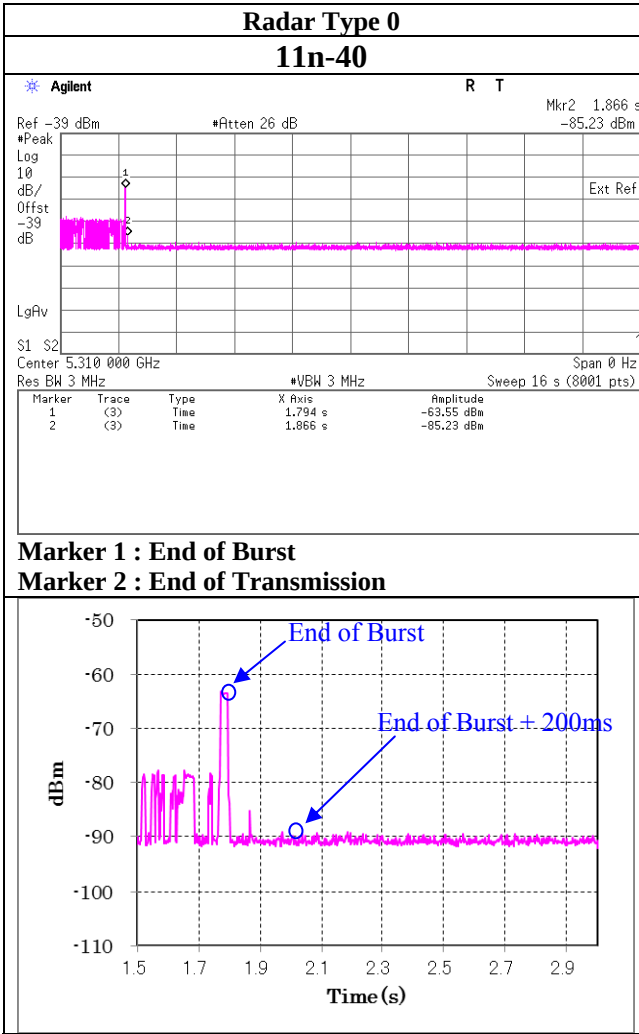
*1) Channel Move Time is calculated as follows:

(Channel Move Time) = (End of Transmission) - (End of Burst) = 1.866-1.794

*2) Channel Closing Transmission Time is calculated from (End of Burst + 200msec) to (End of Burst + 10sec)

(Channel Closing Transmission Time) = (Number of analyzer bins showing transmission) × (dwell time per bin)

= 0 × 2[msec]



6.4 Test result

Test result: Pass

SECTION 7: Non-Occupancy Period

7.1 Operating environment

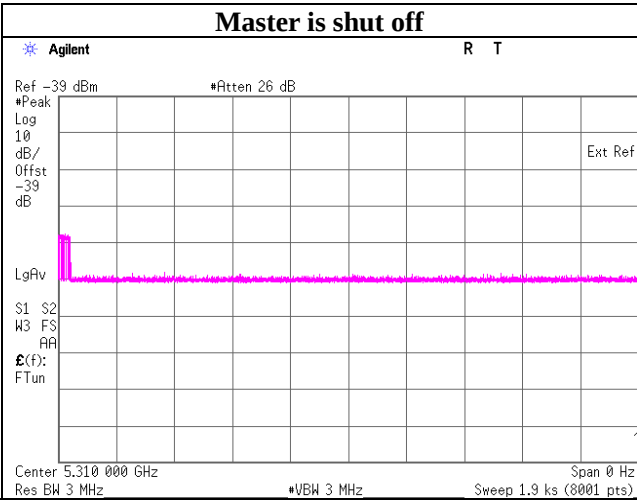
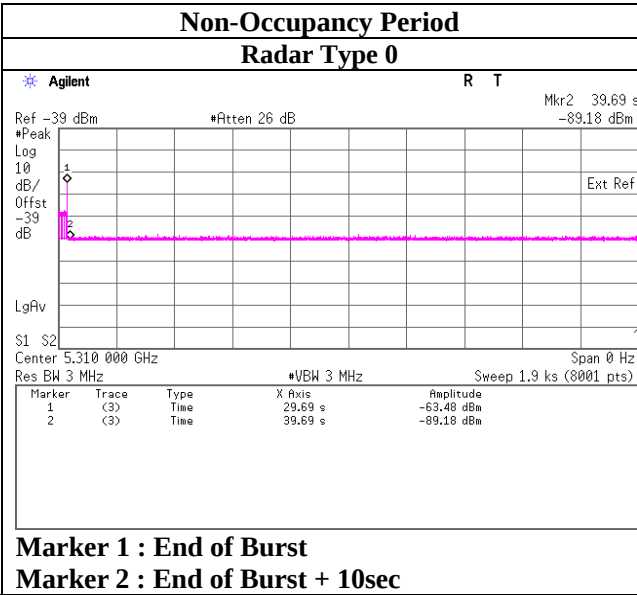
Test place	Ise EMC Lab. No.6 shielded room
Date	05/10/2016
Temperature/ Humidity	24deg. C / 62% RH
Engineer	Takumi Shimada
Mode	11n-40

7.2 Test Procedure

The following two tests are performed:

- 1). Transmit the data from the Master Device to the Client Device on the test Channel for the entire period of the test. The Radar Waveform generator sends a Burst of pulses for Radar Types 0 at levels defined on the Operating Channel. An additional 1 dB is added to the radar test signal to ensure it is at or above the DFS Detection Threshold, accounting for equipment variations/errors.
Observe the transmissions of the EUT after the Channel Move Time on the Operating Channel for duration greater than 30 minutes.
- 2). Transmit the data from the Master Device to the Client Device on the test Channel for the entire period of the test. Observe the transmissions of the EUT on the Operating Channel for duration greater than 30 minutes after the Master Device is shut off.

7.3 Test data



7.4 Test result

Test result: Pass

APPENDIX 1: Test instruments

EMI Test Equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MSA-03	Spectrum Analyzer	Agilent	E4448A	MY44020357	DFS	2015/05/18 * 12
EST-48 *1)	Signal Generator	Agilent	E4438C	MY45090353	DFS	2015/12/30 * 12
MCC-179	Microwave Cable	Junkosha	MMX221-00500DMSDMS	1502S306	DFS	Pre Check
MCC-189	Microwave Cable	Junkosha	MWX-221-02000DMSDMS	1507S108	DFS	Pre Check
MCC-190	Microwave Cable	Junkosha	MWX-221-02000DMSDMS	1507S109	DFS	Pre Check
MAT-57	Attenuator(10dB)	Suhner	6810.19.A	-	DFS	2016/01/18 * 12
MAT-58	Attenuator(10dB)	Suhner	6810.19.A	-	DFS	2016/01/18 * 12
MAT-59	Attenuator(20dB)	Suhner	6820.19.A	-	DFS	Pre Check
MAT-60	Attenuator(20dB)	Suhner	6820.19.A	-	DFS	Pre Check
MAT-61	Attenuator(20dB)	Suhner	6820.19.A	-	DFS	Pre Check
COTS-MDFS-01	Signal Studio Software for DFS	Agilent	N7620A-101	5010-7739	DFS	-
COTS-MDFS-02	Radar Generating Software for DFS	Agilent	-	-	DFS	-
MOS-14	Thermo-Hygrometer	Custom	CTH-201	1401	DFS	2016/01/21 * 12

***1) Signal generator is only used to generate radar test signal, and the wave form is confirmed with spectrum analyzer every time before the test.**

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

DFS: Dynamic Frequency Selection

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